Construction of Mixed-Level Orthogonal Arrays for Testing in Digital Marketing

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Webtrends

October 19, 2012

Advantages of Conducting Designed Experiments in Digital Marketing

- Availability of Data
- Ease of Creating Tests
- Automation of the Analysis

Challenges of Conducting Designed Experiments in Digital Marketing

- Wide Range of Factor-Level Combinations, Including Mixed-Level Designs
- ▶ Binary and continuous response variable
- Designs Must Be Small
- Designs Must Be Robust
- Must Isolate Effects
- Must Produce Results Fast
- Unsophisticated Users Robustness

- Motivation
- Fractional Factorial Design
- Clear Effects
- Minimum Aberration Criterion
- Orthogonal Array Construction
- Conclusion

Fractional Factorial Design

Motivation: for economic reasons, full factorial designs are seldom used in practice for large k ($k \ge 7$).

Fractional Factorial Design: a subset or fraction of full factorial designs.

- "Optimal" fractions: are chosen according to the resolution or minimum aberration criteria.
- Aliasing of effects: a price one must pay for choosing a smaller design.

Design r^{k-p} , where

- r: level of the factors.
- k: number of the factors.
- p: number of design generators.
- $ightharpoonup n = r^{k-p}$: run size.

An Example

No.	Α	В	C	D	Ε
1	_	+	+	_	_
2	+	+	+	+	_
3	_	_	+	+	_
4	+	_	+	_	_
5	_	+	_	+	_
6	+	+	_	_	_
7	_	_	_	_	_
8	+	_	_	+	_
9	_	+	+	_	+
10	+	+	+	+	+
11	_	_	+	+	+
12	+	_	+	_	+
13	—	+	_	+	+
14	+	+	_	_	+
15	_	_	_	_	+
16	+	_	_	+	+

Balance and Orthogonality

Two key properties of the designs: **balance** and **orthogonality**.

- Balance: Each factor level appears in the same number of runs.
- Orthogonality: Two factors are called orthogonal if all their level combinations appear in the same number of runs. A design is called orthogonal if all pairs of its factors are orthogonal.

Design Generators

- ▶ 2^{5-1} design: 16 runs, which is a $\frac{1}{2}$ fraction of a 2^5 full factorial design.
- ▶ Aliasing: D and ABC, i.e., main effect of D is aliased with the $A \times B \times C$ interaction.
- ► The aliasing is denoted by the **design generator** D = ABC, $x_4 = x_1 + x_2 + x_3 \pmod{2}$.
- Since $2x_4 = x_1 + x_2 + x_3 + x_4 = 0 \pmod{2}$, we can get the **defining relation** $I = ABCD \ (I = 1234)$.

	Number	Factors
Main effects	5	A,B,C,D,E
Two-factor	10	AB,AC,AD,AE,BC,,DE
Three-factor	10	ABC,ABD,ABE,BCD,,CDE
Four-factor	5	ABCD,ABCE,ABDE,ACDE,BCDE
Five-factor	1	ABCDE

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Clear Main Effects and Two-factor Interaction Effects

Clear effect: a main effect or two-factor interaction is clear if none of its aliases are main effects or two-factor interactions.

	Number	Factors	
Main effects	5	A,B,C,D,E	
Two-factor	4	AE,BE,CE,DE	

From $x_1 + x_2 + x_3 + x_4 = 0 \pmod{2}$, we can get:

- ▶ A = BCD, B = ACD, C = ABD, so all the main effects are clear.
- ► AB = CD, AC = BD, AD = BC, ..., AE = BCDE, BE = ACDE, CE = ABDE, DE = ABCE, so only the two-factor interactions including E are clear, all the others aliased with other two-factor interactions.

More Than One Design Generators

Consider the 2^{6-2} design with design generators: E = AB, F = ACD.

- ► We get the **defining contrast subgroups**: I = ABE = ACDF = BCDEF.
- ▶ A_i : the number of words of length i in its defining contrast subgroup, wordlength pattern $W = (A_3, A_4, ..., A_k)$.
- ▶ **Resolution**: the smallest r such that $A_r \ge 1$, i.e., the length of the shortest word in the defining contrast subgroup.
- ▶ The above design, resolution R = 3 and W = (1, 1, 1, 0, 0, ...).
- ▶ Maximum Resolution Criterion: Box and Hunter (1961).
- Resolution III design, some main effects are not clear.
- Resolution IV design, main effects are clear, those with the largest number of clear two-factor interactions are the best.
- Resolution V design, two-factor interactions are clear.



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Minimum Aberration Criterion

- ▶ Question: for the same r^{k-p} designs d_1 and d_2 with different design generators, which one is better?
- ► Consider the following two 2⁷⁻² designs:

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d_1: I = 4567 = 12346 = 12357, d_2: I = 1236 = 1457 = 234567.
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- Fries and Hunter (1980): For any two 2^{k-p} designs d_1 and d_2 , let r be the smallest integer such that $A_r(d_1) \neq A_r(d_2)$. Then d_1 is said to have **less aberration** than d_2 if $A_r(d_1) < A_r(d_2)$. If there is no design with less aberration than d_1 , then d_1 has **minimum aberration**.
- For the above d_1 and d_2 , we have wordlength patterns: $W(d_1) = (0, 1, 2, 0, 0)$, $W(d_2) = (0, 2, 0, 1, 0)$, so d_1 is better than d_2 .

Maximum Number of Clear Effects Criterion

► Consider the following two 2⁹⁻⁴ designs:

$$d_1$$
: 6 = 123,7 = 124,8 = 125,9 = 1345,
 d_2 : 6 = 123,7 = 124,8 = 134,9 = 2345.
 d_1 : $I = 1236 = 1247 = 1258 = 3467 = 3568 = 4578,$
 d_2 : $I = 1236 = 1247 = 1348 = 3467 = 2468 = 2378 = 1678.$

▶ For the above d_1 and d_2 , we have:

$$A_3(d_1) = A_3(d_2) = 0$$
,
 $A_4(d_1) = 6 < A_4(d_2) = 7$,
so d_1 is better than d_2 from minimum aberration criterion.

▶ While all the 9 main effects in d_1 and d_2 are clear, d_2 has 15 clear two-factor interactions but d_1 has only 8, so one would judge that d_2 is better than d_1 .

Experiments at Mixed Levels

- ▶ When r = 3, $A \times B$: AB, AB^2 , $A \times B \times C$: ABC, ABC^2 , AB^2C , AB^2C^2 .
- Consider a $2^{3-1} \times 3^{3-1}$ (asymmetric) **product** design: d_1 : C = AB for the two-level factors A, B, C; I = ABC. d_2 : D = EF for the three-level factors D, E, F; $I = DEF^2$.
- ▶ Type 1: find 3 aliasing relations A_1 , A_2 , A_3 of the two-level factors A, B, C, from C = AB:

$$A_1$$
: $A = BC$
 A_2 : $B = AC$
 A_3 : $C = AB$

▶ Type 2: find 4 aliasing relations B_1 , B_2 , B_3 , B_4 of the three-level factors D, E, F, from D = EF:

$$B_1$$
: $D = DE^2F = EF^2$
 B_2 : $E = DF^2 = DE^2F^2$
 B_3 : $F = DE = DEF$
 B_4 : $DE^2 = DF = EF$.

Experiments at Mixed Levels (Continued)

Type 2 aliasing relations: C_1 (from A_1 and B_1): $AD = ADE^2F = AEF^2 = BCD = BCDE^2 = BCDEF^2$. C_2 (from A_1 and B_2): $AE = ADF^2 = ADE^2F^2 = BCE = BCDF^2 = BCDE^2F^2$. C_3 : AF = ADE = ADEF = BCF = BCDE = BCDEF. C_{Δ} : $ADE^2 = ADF = AEF = BCDE^2 = BCDF = BCEF$. C_5 : $BD = BDE^2F = BEF^2 = ACD = ACDE^2F = ACEF^2$. C_6 : $BE = BDF^2 = BDE^2F^2 = ACE = ACDF^2 = ACDE^2F^2$. C_7 : BF = BDE = BDEF = ACF = ACDE = ACDEF. C_8 : $BDE^2 = BDF = BEF = ACDE^2 = ACDF = ACEF$. C_0 : $CD = CDE^2F = CEF^2 = ABD = ABDE^2F = ABEF^2$. C_{10} : $CE = CDF^2 = CDE^2F^2 = ABE = ABDF^2F = ABDE^2F^2$. C_{11} : CF = CDE = CDEF = ABF = ABDE = ABDEF. C_{12} : $CDE^2 = CDF = CEF = ABDE^2 = ABDF = ABEF$.

▶ Type 3: find 12 aliasing relations C_1 to C_{12} from Type 1 and

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Orthogonal Array Construction Problem

Problem: given factors vector, R, how to construct the orthogonal array (OA) (design matrix) that has the minimum possible run size n?

- ightharpoonup R=3 or R=4 for symmetric design.
- For asymmetric design, we define $R = min(R_1, R_2, ..., R_m)$. Sometimes have to be R = 1.
- ▶ level= $(r_1, ..., r_1, r_2, ..., r_2, ..., r_k, ..., r_m)$. For example, level=(2,2,2,3,3,3,3) or level=(2,2,2,2,3,3,3,3).
- ▶ minimum possible run size $n \Longrightarrow$ minimum possible run size vector $n = (n_1, n_2, ..., n_m) \Longleftrightarrow$ maximum possible $p = (p_1, p_2, ..., p_m)$.
- ▶ Get $(OA_1, OA_2, ..., OA_m)$, then cross them together to get the (asymmetric) product design OA.

Maximum Possible p Table

Problem: in each symmetric group, given r, k, R, how to get the maximum possible p?

For r=2:

For r=3:

Notice: For r=2, it might be not compatible for some given R. FYI, for (2,2,2,2) and R=3, we can only assign 1 design generator 3=12, then factor 4 will be the extra factor.

An Example

No.	Α	В	C	D
1	_	+	_	+
2	+	+	+	+
3	_	_	+	+
4	+	_	_	+
5	_	+	_	_
6	+	+	_	_
7	_	_	_	_
8	+	_	_	–

- For factors A, B, C, it is a 2^{3-1} design with design generator C = AB, and D is the extra factor. A, B, C, D makes a
- ▶ $2^{3-1} \times 2$ product design.
- ▶ It is a design with $R = min(R_1, R_2) = min(3, 1) = 1$.

Orthogonal Array Construction Algorithm

Inputs and outputs of the function codes:

- Input: level vector, R.
- ▶ Output: OA ($OA_1, OA_2, ..., OA_m$ are intermediate outputs).

Algorithm:

- (1) From R, generator all the possible resolution combination vector $(R_1, R_2, ..., R_m)$.
- (2) In each symmetric group (given r, k, R_i), check the compatibility of the given level and resolution R_i .
 - If not, stop.
 - If yes, continue to step (2).
- (3) In each symmetric group (given r, k, R_i), find the maximum possible p.
- (4) In each symmetric design (given r, k, p_i), get all the possible design generators (d.g).

Orthogonal Array Construction Algorithm (Continued)

- (5) In each symmetric design (given r, k, d.g), from all the possible design generators, get the one which can achieves the minimum aberration.
 - ► For each possible design generators, get the wordlength.
 - Rank all the wordlengths through minimum aberration criterion.
 - ▶ Pick up the best wordlength, find its corresponding design generators $(d.g_o)$.
- (6) In each symmetric design (given r, k, $d.g_o$), generate the OA_i .
- (7) Cross all the OA_i s to get the product design OA.

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Conclusions

- ▶ We introduce the basic ideas of fractional factorial design, design generators and minimum aberration criterion.
- ► We generalize all the ideas from symmetric design to asymmetric (mixed-level) design.
- ▶ We provide an algorithm to generate the orthogonal array based on the minimum aberration criterion.

References

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